

Cite this: *RSC Appl. Interfaces*, 2024, 1, 1222

# (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc as an air-stable, high-performance n-type semiconductor with poor cannabinoid sensing capabilities†

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Organic thin-film transistors (OTFTs) are an emerging platform for rapid, point-of-source detection and speciation of  $\Delta^9$ -tetrahydrocannabinol (THC) and cannabidiol (CBD). (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc semiconductor was implemented into high performance, air-stable n-type bottom gate, bottom contact OTFTs, however, the resulting device performance changes in response to THC and CBD were negligible. We explored the orientation of the corresponding thin films by synchrotron-based grazing incidence wide-angle X-ray scattering (GIWAXS) and angle-dependent near-edge X-ray absorption fine structure (NEXAFS), as well as polarized Raman microscopy. These techniques demonstrate for the first time that (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc molecules are at a 45–48° orientation to the substrate; comparable to other reported R<sub>2</sub>-SiPcs. This orientation did not change upon exposure to THC and CBD, which has previously been reported for phthalocyanine-based OTFT cannabinoid sensors. The presence of two bulky axial groups, along with the absence of hydrogens in the molecule and the low reactivity of the silicon atom likely causes the lack of interaction with the cannabinoids. While (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc may be a successfully air-stable n-type semiconductor for OTFTs, the structural changes performed to make it air stable over traditional non-fluorinated silicon MPcs, are likely responsible for its lack of response to cannabinoid exposure.

Received 29th April 2024,  
Accepted 13th June 2024

DOI: 10.1039/d4lf00147h

rsc.li/RSCApplInter

## Introduction

Organic thin-film transistors (OTFTs) are an exciting platform for the detection of various chemical and biological analytes.<sup>1–5</sup> Low temperature manufacturing and fine tuning of the semiconductor structure enable a wide breadth of highly sensitive and selective sensors. One interesting potential application for OTFT sensors is for the detection and speciation of  $\Delta^9$ -tetrahydrocannabinol (THC) and cannabidiol (CBD).<sup>6</sup> As cannabis and its products are becoming increasingly legalized and regulated in countries around the world, it has become necessary to quickly and

accurately predict cannabinoid content in a variety of source samples.<sup>7</sup> Previously, our group has demonstrated that OTFT sensors, using metal phthalocyanines (MPcs) as the semiconductor, can effectively detect and differentiate THC and CBD in both solution and vapor samples.<sup>6,8–11</sup> THC and CBD interact with the inner nitrogen ring and central metal of the MPc molecule,<sup>11</sup> leading to unique recrystallization and film reorganization that drives the changes in device performance.<sup>8,11</sup> The choice of peripheral functional groups or metal inclusion within the macrocycle of the MPc has a significant effect on this recrystallization and the sensor response.<sup>8,9,11,12</sup> When using trivalent MPcs such as aluminum Pc (R-AlPc),<sup>8,10</sup> the axial group can be optimized to enhance film interactions and the response to cannabinoids.<sup>12</sup> In most cases, the use of divalent and trivalent MPcs as the semiconductor leads to p-type OTFT operation and hole transporting sensors, which result in a turn-off response upon exposure to cannabinoids. Silicon phthalocyanines (R<sub>2</sub>-SiPcs), are tetravalent MPcs that have demonstrated n-type behaviour, with good electron mobilities and operation in OTFTs<sup>13–17</sup> and organic photovoltaics (OPVs).<sup>18–22</sup> Our group has reported extensively on the fabrication of OTFTs using R<sub>2</sub>-SiPcs, with studies focused on contact engineering,<sup>23</sup> dielectric interface engineering,<sup>14,24,25</sup>

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† Electronic supplementary information (ESI) available. See DOI: <https://doi.org/10.1039/d4lf00147h>



thin film processing,<sup>14–16,26</sup> axial group functionalization,<sup>16,17,24,27–29</sup> and more.<sup>30–33</sup> To date, R<sub>2</sub>-SiPcs have never been reported as the semiconductor in OTFT based cannabinoid sensors due to their poor air stability. Recently, we reported the air stable OTFT operation of fluorinated R<sub>2</sub>-SiPcs due to the increased electron withdrawing nature of the fluorine groups, deepening the LUMO level and increasing its air stability.<sup>13,21,27</sup> Bis(pentafluorophenoxy) hexadecafluoro silicon(iv) phthalocyanine ((F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc)<sup>13</sup> has demonstrated good air-stable n-type performance in OTFTs and is a promising candidate for further development.

In this study, we explore the use of (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc as the semiconductor in OTFT based cannabinoid sensors. The OTFT sensors did not respond to the presence of CBD or THC. Upon study of the thin films, including novel characterization of these materials, we demonstrate the surprising lack of change with exposure to cannabinoids.

## Results and discussion

### Transistor characterization

Bottom-gate bottom-contact (BGBC) devices were fabricated with a thermally evaporated 50 nm layer of (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc as the semiconductor on octyl trichlorosilane (OTS)-functionalized SiO<sub>2</sub> as the dielectric with Au electrodes ( $W = 10$  mm,  $L = 10$  μm) (Fig. 1a). F<sub>2</sub>-F<sub>16</sub>-SiPc was synthesized according to a previously reported literature procedure,<sup>27</sup> and the axial functionalization to obtain (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc was adapted from an original reaction by Vebber *et al.*<sup>13</sup> During this synthesis, single crystal data was not able to be obtained.

The output and transfer curves from a representative device tested in air are shown in Fig. 1b and c. The average electron mobility ( $\mu_e$ ) was  $0.04 \pm 0.01$  cm<sup>2</sup> V<sup>-1</sup> s<sup>-1</sup>, with a threshold voltage ( $V_T$ ) of 9.9 V and a median on-current ( $I_{On}$ ) of 0.32 mA, from a minimum of 20 transistors. These results surpass our previously recorded performance for (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc in air (Table S1, ESI<sup>†</sup>), which were obtained in a bottom-gate top-contact (BGTC) architecture using Ag electrodes ( $W = 1$  mm,  $L = 30$  μm).<sup>13</sup> The improved performance is likely due to the improved electrode architecture and electrode material. While BGBC architectures are generally associated with higher contact resistance and reduced performance, the increased  $W/L$  would lead to an increased overall channel surface area, improving  $\mu_e$  and  $I_{On}$ , as charge could move through the channel more quickly.

The resulting (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc OTFTs were exposed to THC and CBD vapor (Fig. 2). A substrate was also left out in air for the time taken to expose and test the other devices to compare any changes in performance to those experienced by air exposure (control). As shown in Fig. 2, negligible changes in transfer characteristics were observed, where changes in  $\mu_e$  and  $V_T$  were within statistical error of the controls. Unlike when using fluorinated copper MPc (F<sub>16</sub>-CuPc),<sup>6</sup> another n-type semiconductor, the  $V_T$  did not reliably decrease for both cannabinoids, which would be indicative of a turn-on response. However, the  $\mu_e$  was found to decrease as it had for F<sub>16</sub>-CuPc, though not significantly more than what was experienced by the control. Interestingly, the defect density,  $N$ , for the exposed samples was shown to increase in relation to the air-only sample, indicating that exposure to cannabinoids potentially introduces additional charge traps to the film, which may help explain the slightly reduced  $\mu_e$ .

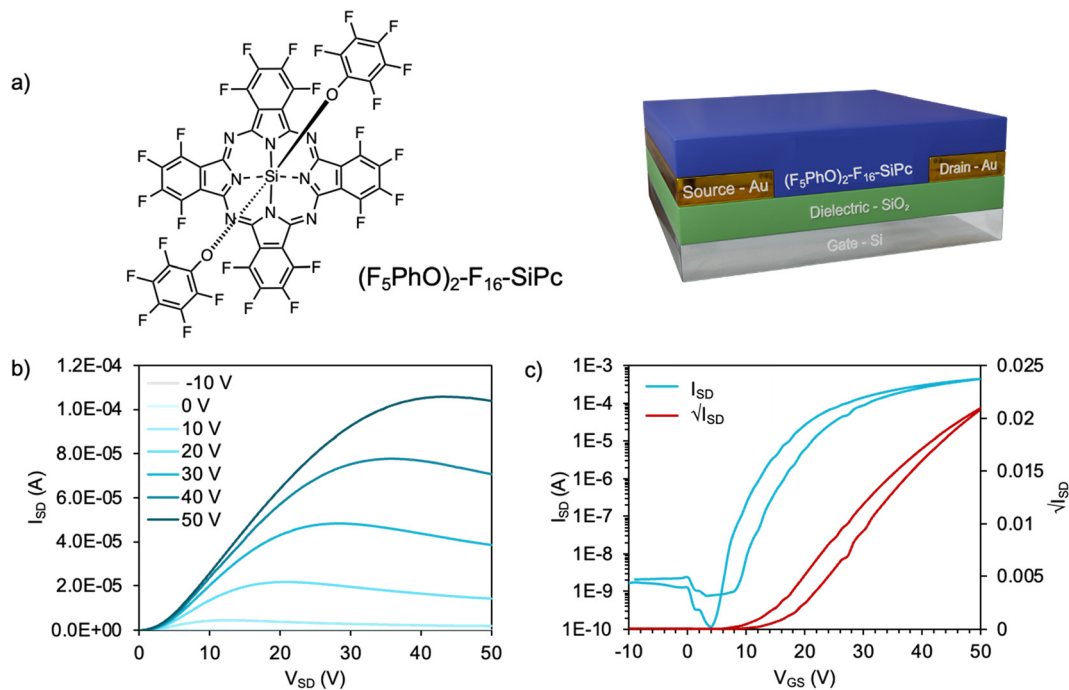
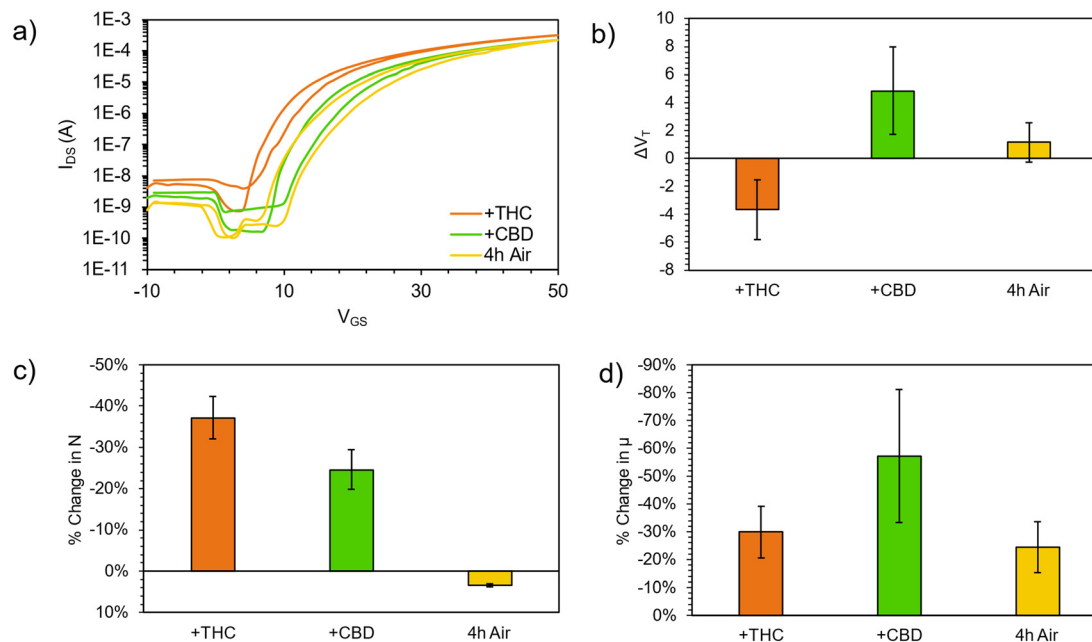


Fig. 1 (a) (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc chemical structure, and the bottom-gate bottom-contact (BGBC) device architecture used in this study, along with the associated (b) output curves and (c) transfer curves ( $V_{SD} = 50$  V) of the (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc OTFTs tested in air.





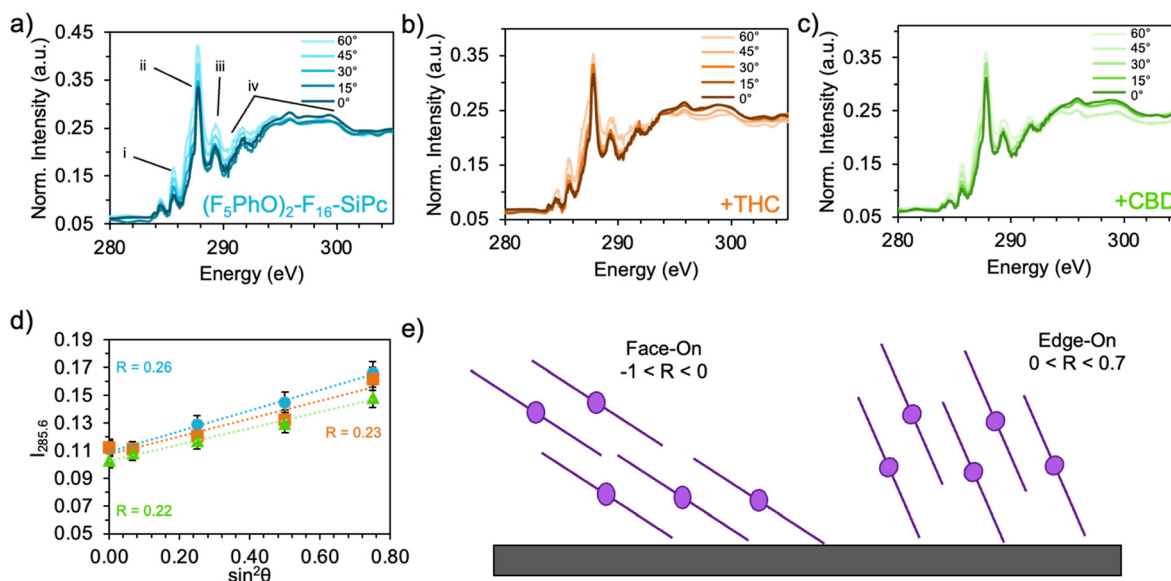
**Fig. 2**  $(F_5PhO)_2-F_{16}-SiPc$  performance after exposure to THC and CBD, or after 4 h of air exposure as a control, demonstrated by the (a) transfer curve ( $V_{SD} = 50$  V) of a representative device, (b) average change in threshold voltage,  $V_T$ , (c) average change in defect density,  $N$ , and (d) the average change in electron mobility,  $\mu_e$ . All averages are for a minimum of 10 transistors.

Regardless, we could not conclusively detect the cannabinoids using  $(F_5PhO)_2-F_{16}-SiPc$  OTFTs.

### Thin-film characterization

Typically, MPc films experience significant changes in morphology and orientation when exposed to cannabinoid

vapors or solutions.<sup>8–10,12</sup> Therefore,  $(F_5PhO)_2-F_{16}-SiPc$  films were characterized using various synchrotron based techniques, for the first time, to investigate if any morphological or orientational changes would occur upon exposure to cannabinoids. In the absence of single-crystal data, multiple techniques were used in combination to characterize the film structure.



**Fig. 3** (a) Normalized angle-dependent NEXAFS spectra for the baseline  $(F_5PhO)_2-F_{16}-SiPc$  film, (b) after exposure to THC, and (c) after exposure to CBD. Features of the spectrum are highlighted by (i–iv). (d) The intensity of the peak of the  $\pi_{C=C}^*$  transition of the SiPc plane was plotted against  $\sin^2\theta$  to generate a linear fit, allowing the calculation of the dichroic ratio,  $R$ , for each film, which indicates tendency towards face-on or edge-on orientation of the molecules to the surface, as shown in (e).



Angle-dependent near-edge X-ray absorption fine structure (NEXAFS) was performed at the carbon K-edge (280–310 eV) using monochromatic synchrotron X-ray beam polarized to linear horizontal (LH), where 50 nm films of  $(F_5PhO)_2-F_{16}-SiPc$  on a SiN membrane were rotated between  $0^\circ$  and  $60^\circ$  with respect to the sample surface normal (Fig. 3). The rotation of the sample causes a change in the relative intensity of peaks in the NEXAFS spectra.<sup>34</sup> By plotting the intensity of the peak associated with the  $\pi_{C=C}^*$  bonds in the SiPc macrocycle, we can determine if the majority of the molecules in the film are more face-on or edge-on by determining the dichroic ratio,  $R$  (Fig. 3d and e).<sup>35–38</sup> In the NEXAFS spectrum of  $(F_5PhO)_2-F_{16}-SiPc$  (Fig. 3a) there are four major features: (i) a peak at 285.6 eV associated with the 1 s to  $\pi_{C=C}^*$  transition in unsaturated carbon bonds in the SiPc plane, (ii) a strong peak at 287.8 eV that can be attributed to the highly shifted  $\pi_{C=C}^*$  from the fluorinated phenoxy substituents, (iii) a peak at 289 eV that is likely the highly shifted  $\pi_{C=C}^*$  from the fluorinated substituents from the SiPc plane, and (iv) the multiple broad peaks above 293 eV associated with the 1 s to  $\sigma_{C-C}^*$  transitions.<sup>32</sup> This spectra corresponds closely to that collected for  $(F_5PhO)_2-SiPc$ , with the addition of the signal at 289 eV for the additional peripheral fluorines.<sup>32</sup> To determine the orientation of the SiPc macrocycle plane to the substrate surface, the intensity of the 285.6 eV signal was plotted against the angle of substrate rotation to generate a linear fit. This intensity increases with increasing angle of rotation, exhibiting dichroic behaviour and allowing the calculation of  $R$ , determined to be 0.26 for the baseline  $(F_5PhO)_2-F_{16}-SiPc$  film (eqn (4)). This indicates a slight preference towards a pseudo

edge-on orientation for molecules throughout the film, inclusive of both crystalline and amorphous regions. Edge-on orientation is preferred for OTFT applications, enabling charge transport through the film.

Angle-dependent NEXAFS was also performed on  $(F_5PhO)_2-F_{16}-SiPc$  films after exposure to THC and CBD (Fig. 3b and c), where the same spectral features were observed, and the intensity of the  $\pi_{C=C}^*$  peak increased with increasing substrate rotation. The calculated  $R$  for the THC and CBD exposed samples was 0.23 and 0.22, respectively, indicating that the molecules remained primarily edge-on after cannabinoid exposure. Previous cannabinoid sensors, such as those fabricated with zinc Pc (ZnPc) and Cl-AlPc and its substituted derivatives, saw success due to their ability to adopt new polymorphs and crystal structures in films after exposure to cannabinoids.<sup>8–10,12</sup> This small change in  $R$  experienced by  $(F_5PhO)_2-F_{16}-SiPc$  indicates that this molecule does not undergo this same crystal rearrangement, and may be more stable in its thin film structure than other MPcs.

The  $(F_5PhO)_2-F_{16}-SiPc$  films were also analyzed by polarized Raman microscopy, where  $Z(XX)Z'$  and  $Z(XY)Z'$  polarized Raman spectra were collected every  $0.5 \mu m$  over a  $10 \times 10 \mu m$  area over the  $(F_5PhO)_2-F_{16}-SiPc$  surface. The full baseline Raman spectrum can be found in Fig. S1 (ESI†). As we have previously demonstrated,<sup>26</sup> we can use the ratio of intensities of the isoindole peak of the SiPc ( $\sim 1555 \text{ cm}^{-1}$  in this case) at each polarization to find the average orientation of the SiPc molecule to the surface with eqn (3).<sup>26,39–43</sup> The results were mapped on a contour plot (Fig. 4a–c), and the angle distribution plotted (Fig. 4d–f), showing an average molecular orientation of  $47.8^\circ$  to the surface for the baseline

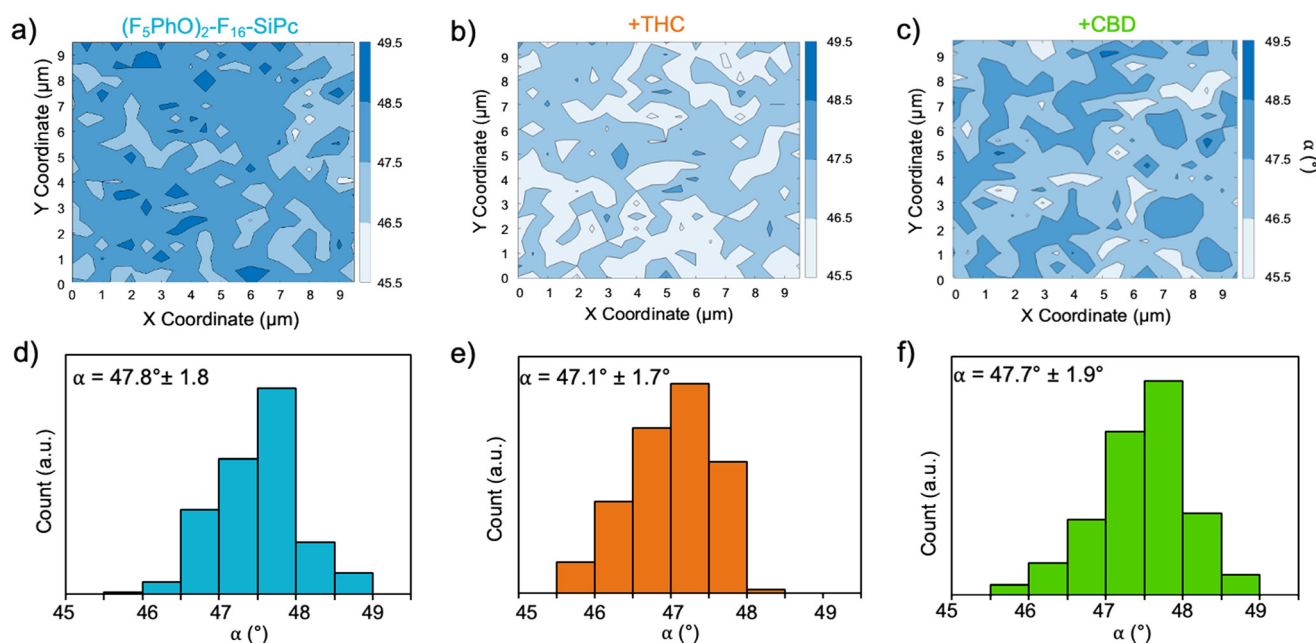


Fig. 4 Polarized Raman microscopy mapping on a  $10 \times 10 \mu m$  area with a  $0.5 \mu m$  step size to generate a contour plot of the average  $(F_5PhO)_2-F_{16}-SiPc$  angle to the surface, with the angle distribution for the (a and d) baseline  $(F_5PhO)_2-F_{16}-SiPc$  film, (b and e) after exposure to THC, and (c and f) after exposure to CBD.



(F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc film (Fig. 4d). The distribution of average angles is tight, ranging from a minimum of 45.5° to a maximum of 49.5°. This is to be expected for a film deposited by physical vapor deposition, and is consistent with previous studies for vapor deposited R<sub>2</sub>-SiPcs, where angles between 44° and 52° have been found by polarized Raman microscopy.<sup>26</sup> This calculated orientation is slightly more edge-on than face-on, supporting the NEXAFS results. Raman maps and angle distribution plots were also generated for the cannabinoid exposed samples (Fig. 4b, c, e and f), where the average angles were determined to be within standard deviation from the baseline sample. Again, this supports the NEXAFS results, indicating that (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc films did not significantly change upon exposure to cannabinoids.

Grazing-incidence wide-angle X-ray scattering (GIWAXS) is a useful technique to identify the molecular structure and crystallinity of MPc thin films. As seen in Fig. 5a–c, 2D GIWAXS spectra was obtained for the (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc films, and the corresponding diffraction pattern was generated

(Fig. 5d). The resulting pattern has very sharp, spot-like scattering features throughout, indicating a high level of crystallinity with narrow orientation distributions through the film; similar to what has been seen with (F<sub>5</sub>PhO)<sub>2</sub>-SiPc on OTS-treated substrates.<sup>24</sup> The  $\pi$ - $\pi$  stacking diffraction signal of MPcs attributed to the orientation of the central Pc plane is known to be associated with peaks in the upper  $q$ -range, around 1.7–2.1.<sup>9,10,16,24,25</sup> Integration of the linecut profile of the GIWAXS spectra in a  $q$ -range of 1.7–1.9 (Fig. 5e), corresponding with the peak in the diffraction pattern indicated by (v) in Fig. 5d, gives a predominant (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc angle of 45° to the substrate, with less intense peaks at 21°, 32°, 55°, and 83° indicating a mixed orientation film. These results agree with those observed by both Raman and NEXAFS, and are similar to those obtained previously for (F<sub>5</sub>PhO)<sub>2</sub>-SiPc on OTS by GIWAXS. Multiple orientations have been observed for other R<sub>2</sub>-SiPcs by GIWAXS, depending on their deposition technique and surface treatment,<sup>14,25</sup> but the appearance of the more edge-on orientations of 45°, 55° and

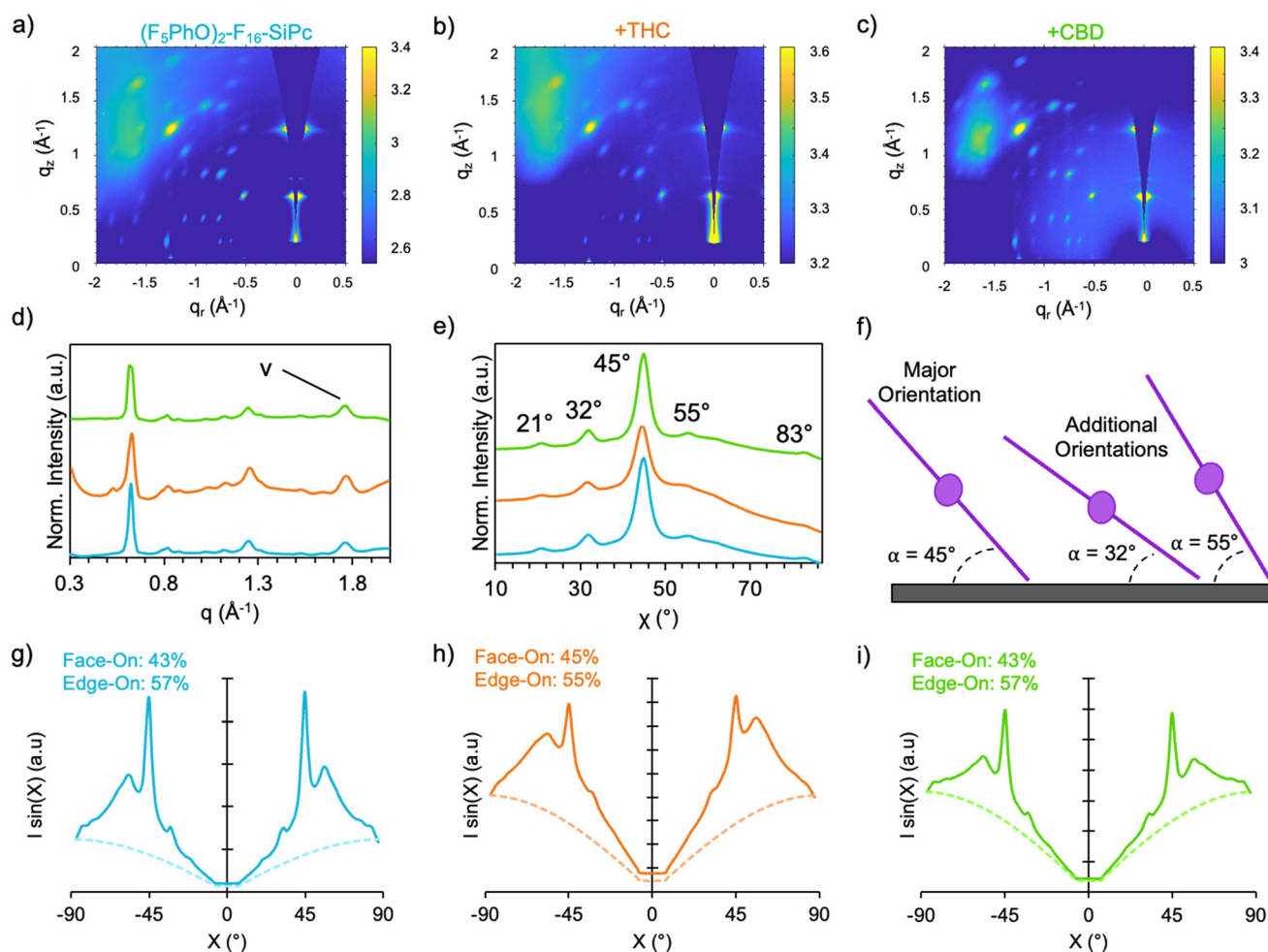


Fig. 5 2D GIWAXS spectra and the corresponding geometrically corrected pole figure for (a and g) the baseline (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc film, (b and h) after THC exposure, and (c and i) after CBD exposure. The pole figures were generated over the entire  $\chi$  range, for a  $q$ -range of 1.7–1.9 to determine the proportion of edge-on and face-on crystallites in the film. The (d) diffraction pattern for each film and (e) non-corrected linecut profile with respect to  $\chi$  for a  $q$ -range of 1.7–1.9 is shown, indicated by (v) in the diffraction pattern. The linecut profile identifies five prevalent molecular orientations, the most common are illustrated in (f).



83° is common for high-performing SiPcs like (F<sub>5</sub>PhO)<sub>2</sub>-SiPc, and causes improved horizontal charge transfer through the film, increasing the  $\mu_e$ .<sup>14,24</sup> In addition to the similar observed orientations, the *d*-spacing of the major peak in the diffraction pattern (Fig. 5d) commonly associated with the 010 and 001 planes of R<sub>2</sub>-SiPcs is nearly identical to that of (F<sub>5</sub>PhO)<sub>2</sub>-SiPc on OTS,<sup>24</sup> at a *q* of 0.62 Å<sup>-1</sup>, indicating a similar packing structure and distance between molecules.

GIWAXS is a higher resolution technique than Raman and NEXAFS for identifying specific polymorphs and molecular angles, but it can only identify the orientation of molecules in crystalline regions of thin films that generate a diffraction pattern (not the amorphous regions), where Raman and NEXAFS identify average orientations through all regions of the film.<sup>44</sup> To further quantify the orientation of these films by GIWAXS, the geometrically corrected pole figure was generated<sup>45-47</sup> in the *q*-range from 1.7–1.9 (Fig. 5g), where the area under the curve was integrated to determine the population of face-on (<45°) and edge-on (>45°) molecules in the central Pc plane. For the baseline (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc film, a 43% population of face-on molecules, and a 57% population of edge-on molecules was calculated. Again, these agree with the previous results from both NEXAFS and Raman, showing a slight preference toward edge-on orientation.

GIWAXS was also performed on (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc films exposed to THC and CBD (Fig. 5b and c), and the same molecular orientations can be observed, with no significant new diffraction pattern indicating the appearance of new polymorphs. As previously mentioned, high performing MPc-based OTFT cannabinoid sensors have experienced significant film reorganization in response to cannabinoids, sometimes with the appearance of new polymorphs, and this has been observed through changes in orientation by GIWAXS.<sup>9,12</sup> (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc did not experience these types of changes in the molecular orientations, or in the relative intensity of these angles, which is consistent with the lack of significant change in device performance upon exposure. Additionally, the pole figures (Fig. 5h and i) did not show a significant change in the population of face-on and edge-on molecules in either of the exposed films.

In previous reports we have explored various MPcs as semiconductors in cannabinoid sensors and have found that the central atom plays a significant role in the sensitivity.<sup>8,11</sup> For example, through solution based spectroelectrochemistry and 2D NMR experiments,<sup>11</sup> along with thin film characterization,<sup>8</sup> we have found that the central metal influences the film morphology and strength of analyte-MPc interactions, where ZnPc and R-AlPc resulted in the most sensitive devices.<sup>9,10,12</sup> The fact that silicon is a relatively inert metalloid rather than a reactive metal, might contribute to the observed reduced interactions. The lack of response is likely not purely due to an energy mismatch from the use of an n-type material, as we have found success previously using the n-type F<sub>16</sub>-CuPc, resulting in a negative *V<sub>T</sub>* shift and reduction in  $\mu_e$ .<sup>6</sup>

We have previously explored different levels of fluorination in ZnPcs with 0, 4, and 16 peripheral fluorine

groups and found that while all were effective sensors, the unfluorinated ZnPc was the most sensitive, resulting in the greatest reduction in  $\mu_n$  and the ability to detect 40 ppb THC vapor.<sup>9</sup> This suggests that reducing the number of hydrogen groups available for hydrogen bonding and interacting with the cannabinoids may negatively impact its sensitivity, which helps to explain the observed reduced performance seen by (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc.

Additionally, this work explores the first use of an R<sub>2</sub>-SiPc in a cannabinoid sensor, which is also the first report of a tetravalent MPc used in these sensors. We surmise the axial groups above and below the central silicon atom prevents significant interaction with the cannabinoid. As THC and CBD were found to primarily interact with the central ring of nitrogens in MPc molecules, the presence of bulky, inflexible axial groups on both sides of the central SiPc plane likely sterically hinder any potential cannabinoid interaction. It would appear that the structural changes required to make (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc a semiconductor for air stable, n-type OTFT operation, has also made it resistant to interactions with cannabinoids, preventing its use as a sensing element.

## Conclusion

We report the application of the air stable n-type semiconductor (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc in BGBC OTFTs. We explored the corresponding thin films by synchrotron based GIWAXS and NEXAFS, as well as polarized Raman microscopy. These complimentary techniques demonstrate for the first time that the (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc molecules are at a 45–48° angle from the substrate with relatively homogeneous morphology, which is comparable to the orientations previously found for (F<sub>5</sub>PhO)<sub>2</sub>-SiPc and other SiPcs. We also explored the use of (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc based OTFTs as cannabinoid sensors and found no statistical difference in performance before and after exposure to CBD and THC. The film characterization also revealed negligible changes in structure with exposure to cannabinoids which has been reported for high performing MPc OTFT cannabinoid sensors. Overall, (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc is among the most air-stable silicon based MPc used in OTFTs, but the very structural changes that lead to this air stability and high performance are what prevent its use as a cannabinoid sensing molecule.

## Experimental methods

### Materials

Tetrafluorophthalonitrile (97%) and pentafluoro phenol (99%) were purchased from Ambeed. Lithium bis(trimethylsilylamide) (97%) was purchased from Sigma Aldrich and the etherate was prepared as outlined in literature.<sup>48</sup> Silicon tetrachloride (99%), boron trichloride (1 M in heptane), anhydrous tetraline, chlorobenzene and (octyl)trichlorosilane (OTS, 97%) were purchased from Sigma Aldrich and used as received. All solvents used in device



fabrication were HPLC grade and purchased from Fisher Scientific. Toronto Research Chemicals supplied the cannabinoid standards.

### Chemical synthesis

**Synthesis of Si<sub>2</sub>Si-difluoro hexadecafluoro silicon(IV) phthalocyanine (F<sub>2</sub>-F<sub>16</sub>-SiPc).** Based from previously reported procedure,<sup>27</sup> tetrafluorophthalonitrile (5 g, 25.0 mmol) was charged in a 500 mL round-bottom flask (RBF) under argon. Anhydrous tetraline (125 mL) was transferred to RBF via cannula and mixture was stirred until phthalonitrile was completely dissolved. LiHMDS-Et<sub>2</sub>O (3.0 g, 12.4 mmol) was added to the solution and stirred for 2 h at room temperature. SiCl<sub>4</sub> (3.54 mL, 30.0 mmol) was added, and the resulting mixture was stirred for 24 h at 200 °C. The mixture was then brought to 50 °C and filtered twice through a coarse porosity fritted funnel. The resulting filter cake was sonicated for 15 min in 200 mL of methanol, refiltered and washed with 150 mL of acetone, then sonicated for 15 min with 150 mL of hexanes and filtered once again. The resulting crude was dried overnight under high vacuum to give the title product as a blue powder (3.17 g), used in subsequent steps without further purification.

**Synthesis of Si<sub>2</sub>Si-dichloro hexadecafluoro silicon(IV) phthalocyanine (Cl<sub>2</sub>-F<sub>16</sub>-SiPc).** Based from previous literature,<sup>27</sup> F<sub>2</sub>-F<sub>16</sub>-SiPc (1.6 g, 1.8 mmol) was dissolved in anhydrous chlorobenzene (60 mL) in a 100 mL RBF under argon. BCl<sub>3</sub> (11.0 mmol) was added, and the resulting mixture was stirred at 130 °C for 72 h. The mixture was then brought to room temperature and filtered under vacuum to recover the crude title product (1.4 g) as a blue powder, which was used in subsequent steps without further purification.

**Synthesis of bis(pentafluorophenoxy) hexadecafluoro silicon(IV) phthalocyanine ((F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc).** Based from previous literature,<sup>13</sup> Cl<sub>2</sub>-F<sub>16</sub>-SiPc (1.4 g, 1.6 mmol) was dissolved in anhydrous chlorobenzene (60 mL) in a 100 mL RBF under argon. pentafluoro phenol (1.6 g, 8.5 mmol) was added and the resulting mixture was stirred at 130 °C for 72 h. The mixture was then brought to room temperature and filtered under vacuum. The resulting filtrate was concentrated down *via* rotary evaporation, then sonicated in 50 mL of MeOH and refiltered to recover a dark blue powder as the crude title product (136 mg). The crude product was further purified *via* train sublimation at 125 mTorr with a temperature of 260 °C using CO<sub>2</sub> as a carrier gas. HR-MS expected mass: 1193.95; obtained mass: 1193.95084.

### Thin-film deposition

Fraunhofer IPMS supplied custom prefabricated devices to make BGBC transistors, each consisting of a 230 nm thermally grown SiO<sub>2</sub> dielectric layer on an Si gate, and prepatterned source-drain electrodes with a *W/L* of 1000 (*W* = 10 mm, *L* = 10 μm). Silicon (Si) substrates from WaferPro were used for GIWAXS sample preparation. The substrates were washed with acetone to remove the photoresist, then

with isopropanol and dried under a N<sub>2</sub> gas stream. They were then treated with oxygen plasma for 15 minutes, briefly rinsed with water, isopropanol, and dried with N<sub>2</sub>. Once dry, they were immersed in a 1% v/v OTS solution in toluene for 1 hour at 70 °C. The substrates were then rinsed with toluene and isopropanol, dried with N<sub>2</sub>, and placed in a vacuum oven at 70 °C for 1 hour to remove trace solvent. The substrates were placed in an Angstrom EvoVac thermal evaporator at a pressure below 2 × 10<sup>-6</sup> Torr, where (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc was deposited by sublimation at 0.2 Å s<sup>-1</sup> until a thickness of 500 Å was reached.

### OTFT characterization

Transistors were tested using a custom-build auto tester machine and run using a Keithley 2614B SourceMeter and Labview software. The *V*<sub>DS</sub> and *V*<sub>GS</sub> were set and the *I*<sub>SD</sub> was measured to obtain both output and transfer curves. Five transfer curves were taken for each transistor and the final three were averaged. From the transfer curve, the *V*<sub>T</sub>, *N* and *μ*<sub>e</sub> could be extracted, the latter using eqn (1), for saturation operation, where *C*<sub>i</sub> is the capacitance.

$$I_{SD} = \frac{\mu C_i W}{2L} (V_{GS} - V_T)^2 \quad (1)$$

Defect density, *N*, was calculated using eqn (2), where the subthreshold slope, *S*, is estimated graphically from the transfer data, *q* is the electronic charge, *k* is the Boltzmann constant, and *T* is the temperature.

$$N = \left( \frac{Sq}{kT \ln(10)} - 1 \right) \left( \frac{C_i}{q} \right) \quad (2)$$

Once the baseline performance of the (F<sub>5</sub>PhO)<sub>2</sub>-F<sub>16</sub>-SiPc devices were assessed, transistors were exposed to either THC vapor (300 ppm concentration) or CBD vapor (300 ppm concentration) by vaporizing a pure cannabinoid sample into an 8 L bag using the Vapormed Volcano Medic. The bag was slowly emptied over the devices in a chamber for 90 seconds. New output and transfer curves were then obtained for all exposed devices, allowing for a comparison with the baseline values.

### GIWAXS characterization

Grazing incidence wide angle X-ray scattering (WAXS) data was collected using the Brockhouse X-ray Diffraction and Scattering (BXDS) low energy wiggler beamline (04ID-2).<sup>49</sup> 04ID-2 employed a Si(111) single side-bounce monochromator crystal to select a photon energy of ~15.1 keV (wavelength = 0.81931 Å). The beamline employs a Huber four-circle diffractometer end-station which was used to select grazing incidence angles of 0.1 and 0.3 degrees. The sample position was oriented using an automated, iterative procedure to scan the sample height and incidence (theta) angle. WAXS data was collected on a Rayonix MX300 CCD detector using a detector distance of ~474 mm to obtain a *Q* value of 2. The sample-detector distance and tilt were calibrated using a silver behenate reference material. Samples and reference materials were



collected with acquisition times ranging from 0.1 to 30 s. Silver behenate (AgBeh) standards were used to calibrate the data, and the data was analyzed using the GIXSGUI software package in MatLab.

### Polarized Raman microscopy and angle mapping

Thin films of  $(F_5PhO)_2-F_{16}-SiPc$  were characterized by polarized Raman microscopy ( $Z(X,X)Z'$  and  $Z(X,Y)Z'$ ) on a Renishaw inVia Quontor confocal Raman microscope, which uses a Leica Microsystems bright field microscope with a DM2700 light source. A 500 mW 532 nm laser with a 2400 l  $mm^{-1}$  grating was used to collect spectra between 550  $cm^{-1}$  and 1700  $cm^{-1}$  at 5% laser power (25 mW) and an exposure time of 2 s. Individual spectra were taken every 0.5  $\mu m$  over a  $10 \times 10 \mu m$  area at  $\times 50L$  microscope magnification at both polarizations for a total of 441 spectra per polarization. With the objective and laser combination used, the Raman microscope has a spectral resolution of 0.3  $cm^{-1}$  (FWHM), a theoretical spatial resolution of 640 nm, and a theoretical depth of focus of 3.0  $\mu m$ . Calibration was performed prior to all measurements against the 520  $cm^{-1}$  silicon reference peak within 0.5  $cm^{-1}$ . The intensity of the Raman peak at 1555  $cm^{-1}$ , the  $B_{1g}$  pyrrole stretch, was obtained by Wire 5.6 inVia software for both polarizations ( $I_{XX}$  and  $I_{XY}$ ) was used to calculate the angle of the planar  $(F_5PhO)_2-F_{16}-SiPc$  core using eqn (3).<sup>26,39–43</sup> The resulting angles were then mapped on a contour plot using MatLab software.

$$\frac{I_{XX}}{I_{XY}} = 2 \cot^2 \alpha \quad (3)$$

A baseline Raman spectrum was also collected for THC and CBD alone and is shown in Fig. S5 (ESI†).

### Near-edge X-ray absorption fine structure (NEXAFS)

Samples for near edge X-ray absorption fine structure (NEXAFS) were prepared on custom substrates purchased from NORCADA Inc with two transparent silicon nitride (SiN) membranes (0.10 mm  $\times$  0.25 mm, thickness = 50 nm) on a Si frame. The membranes were treated with oxygen plasma and OTS following the same procedure as transistor substrate preparation, followed by the deposition of 50 nm of  $(F_5PhO)_2-F_{16}-SiPc$ , taking care to not damage the delicate membrane. After removal from the evaporator, the membranes were inspected for damage under a bright field microscope before NEXAFS characterization.

NEXAFS experiments were conducted using a Research Instruments scanning transmission X-ray microscopy (STXM) apparatus, provided by RI Research Instruments GmbH, Germany, at the HERMES beamline<sup>50</sup> at the synchrotron SOLEIL facility. A Fresnel zone plate with a 25 nm outer zone radius was used to focus a monochromatic X-ray beam onto the sample. The sample was attached to a stage capable of raster scanning and polar angle rotation. A photomultiplier tube (PMT) was used to detect the transmitted X-rays. Polarization switching was facilitated by automated

adjustments of the undulators, all the while preserving beam alignment and flux. Throughout all measurements, the microscope chamber was held under vacuum at a pressure of  $10^{-4}$  mbar. Energy data sets comprised of line scans were acquired at the carbon K-edge, from 280 to 310 eV. For each line scan a region of 5  $\mu m$  length was scanned with step size of 250 nm and a dwell time of 100. The line scans were repeated at various X-ray incident angles ( $\theta$ ) of 0°, 15°, 30°, 45°, and 60° with respect to the sample surface normal. The set up and rotation of sample has been detailed previously by our group.<sup>51</sup>

The dichroic ratio,  $R$ , was calculated using eqn (4), which is an indication of orientation tendency.  $I(90^\circ)$  is determined using the linear fit from the plot of the intensity of the  $\pi_{C=C}^*$  signal ( $I_{285.6}$ ) against  $\sin^2 \theta$ .

$$R = \frac{I(90^\circ) - I(0^\circ)}{I(90^\circ) + I(0^\circ)} \quad (4)$$

Energy calibration was accomplished using the well-resolved 3p Rydberg peak at 294.96 eV of gaseous  $CO_2$ .<sup>52</sup> Data was processed using the aXis2000 software (accessible at <http://unicorn.chemistry.mcmaster.ca/aXis2000.html>) suite. Raw individual energy images were transformed into optical density (OD) images, utilizing the reference intensity ( $I_0$ ) from an uncoated silicon nitride (SiN) membrane sample. To ensure accurate alignment, energy stacks were aligned following the Jacobsen method.

### Data availability

The data that support the findings of this study are available from the corresponding author, BHL, upon reasonable request.

### Conflicts of interest

There are no conflicts to declare.

### Acknowledgements

This work was supported by NSERC Discovery grant RGPIN 2015-05796 (A. J. S.), 2015-05453 (C. S. H.), and 2020-04079 (B. H. L.), the Canada Research Chairs Program 950-230754 (A. J. S.) and 950-230724 (B. H. L.). Student support was acquired through NSERC PGS-D (H. R. L.) and CGS-D (M. C.). GIWAXS was performed at the Canadian Light Source, a national research facility of the University of Saskatchewan, which is supported by the Canada Foundation for Innovation (CFI), the Natural Sciences and Engineering Research Council (NSERC), the National Research Council (NRC), the Canadian Institutes of Health Research (CIHR), the Government of Saskatchewan, and the University of Saskatchewan. The authors would also like to thank Synchrotron SOLEIL for providing beamtime at the HERMES beamline for the NEXAFS characterization.





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